Search Notes

Application/Control N	10
10/765,783	
Examiner	

Applicant(s)/Paten Reexamination	t under
MARX ET AL.	
Art Unit	

Christopher B. Shin

٦	4	00
<b>∣</b> 2	1	82

	SEARCHED		
Class	Subclass	Date	Examiner
710	69-73	3/13/2006	CBS
178	18.01-	3/13/2006	CBS
178	18.06	3/13/2006	CBS
345	156-179	3/13/2006	CBS
307	116	3/13/2006	CBS
341	33	3/13/2006	CBS

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
710	73	3/14/2006	CBS
345	173, 178	3/14/2006	CBS
178	18.06	3/14/2006	CBS
341/33		3/14/2006	CBS

SEARCH NO (INCLUDING SEARCH		)
	DATE	EXMR
PLUS	3/13/2006	CBS
PALM (DOUBLE PATENTING)	3/13/2006	CBS
EAST (USPGPUB, USPAT, EPO, JPO, DERWENT, IBMTDB, DERWENT)	3/13/2006	CBS